

## N-Channel MOSFET



Lead Free Package and Finish

HF Halogen Free

## Applications:

- Adaptor
- Charger
- SMPS

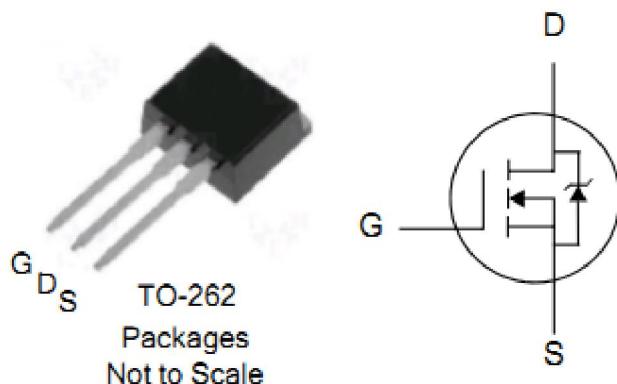
V <sub>DSS</sub>	R <sub>DS(ON)</sub> (Typ.)	I <sub>D</sub>
650V	0.66Ω	12A

## Features:

- RoHS Compliant
- Low ON Resistance
- Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

## Ordering Information

PART NUMBER	PACKAGE	BRAND
ITL12N65R	TO-262	IPS

Absolute Maximum Ratings T<sub>C</sub>=25°C unless otherwise specified

Symbol	Parameter	ITL12N65R	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	650	V
I <sub>D</sub>	Continuous Drain Current	12	A
	Continuous Drain Current T <sub>C</sub> =100°C	7.5	A
I <sub>DM</sub>	Pulsed Drain Current (NOTE *1)	48	A
P <sub>D</sub>	Power Dissipation	150	W
	Derating Factor above 25°C	1.2	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy(NOTE *2)	550	mJ
dv/dt	Peak Diode Recovery dv/dt(NOTE *3)	5	V/ns
T <sub>L</sub>	Maximum Temperature for Soldering	300	
T <sub>J</sub> and T <sub>STG</sub>	Operating Junction and Storage Temperature Range	150, -55 to150	°C

## Thermal Resistance

Symbol	Parameter	Typ.	Units	Test Conditions
R <sub>θJC</sub>	Junction-to-Case	0.83	°C/W	Water cooled heatsink, P <sub>D</sub> adjusted for a peak junction temperature of +150°C.
R <sub>θJA</sub>	Junction-to-Ambient	62.5		1 cubic foot chamber, free air.

**OFF Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	650	--	--	V	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	--	--	1	$\mu\text{A}$	$V_{\text{DS}}=650\text{V}$ , $V_{\text{GS}}=0\text{V}$ $T_J=25^\circ\text{C}$
		--	--	100		$V_{\text{DS}}=520\text{V}$ , $V_{\text{GS}}=0\text{V}$ $T_J=125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	--	--	+100	$\text{nA}$	$V_{\text{GS}}=+30\text{V}$
	Gate-to-Source Reverse Leakage	--	--	-100		$V_{\text{GS}}= -30\text{V}$

**ON Characteristics**  $T_J=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$R_{\text{DS(ON)}}$	Static Drain-to-Source On-Resistance	--	0.66	0.8	$\Omega$	$V_{\text{GS}}=10\text{V}$ , $I_D=6\text{A}$
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2	--	4	V	$V_{\text{DS}}=V_{\text{GS}}$ , $I_D=250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	--	12	--	S	$V_{\text{DS}}=15\text{V}$ , $I_D=6\text{A}$
Pulse width $\leq 300\mu\text{s}$ ; duty cycle $\leq 2\%$						

**Dynamic Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$C_{\text{iss}}$	Input Capacitance	--	1993	--	$\text{pF}$	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=25\text{V}$ $f=1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	--	160	--		
$C_{\text{rss}}$	Reverse Transfer Capacitance	--	9.5	--		
$Q_g$	Total Gate Charge	--	40	--	$\text{nC}$	$I_D=12\text{A}$ , $V_{\text{DD}}=520\text{V}$ $V_{\text{GS}}=10\text{V}$
$Q_{\text{gs}}$	Gate-to-Source Charge	--	10	--		
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	--	14	--		

**Resistive Switching Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$t_{\text{d(ON)}}$	Turn-on Delay Time	--	28	--	$\text{ns}$	$V_{\text{DD}}=325\text{V}$ , $I_D=12\text{A}$ , $V_G=10\text{V}$ $R_G=10\Omega$
$t_{\text{rise}}$	Rise Time	--	26	--		
$t_{\text{d(OFF)}}$	Turn-Off Delay Time	--	64	--		
$t_{\text{fall}}$	Fall Time	--	45	--		

**Source-Drain Diode Characteristics**T<sub>c</sub>=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	--	--	12	A	T <sub>c</sub> =25°C
I <sub>SM</sub>	Maximum Pulsed Current (Body Diode)	--	--	48	A	
V <sub>SD</sub>	Diode Forward Voltage	--	--	1.5	V	I <sub>SD</sub> =12A, V <sub>GS</sub> =0V
t <sub>rr</sub>	Reverse Recovery Time	--	651	--	ns	I <sub>F</sub> = I <sub>S</sub> di/dt=100A/us
Q <sub>rr</sub>	Reverse Recovery Charge	--	4297	--	nC	
Pulse width ≤300μs; duty cycle ≤ 2%						

## Notes:

- \*1. Repetitive rating; pulse width limited by maximum junction temperature.
- \*2. L=10mH, I<sub>D</sub>=10.5A, Start T<sub>J</sub>=25°C
- \*3. I<sub>SD</sub>=12A, di/dt ≤100A/us, V<sub>DD</sub>≤BV<sub>DS</sub>, Start T<sub>J</sub>=25°C

**Characteristics Curve:**

Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case

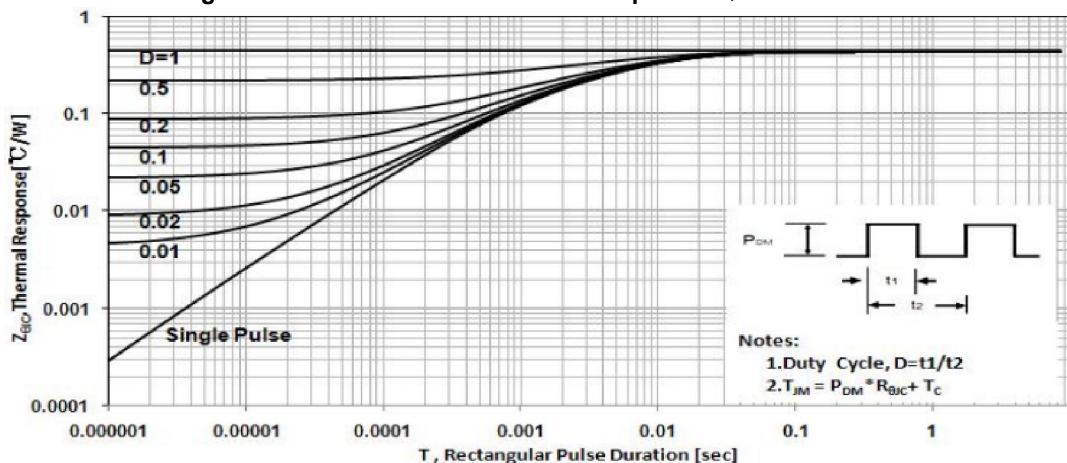


Figure 2. Max. Power Dissipation vs Case Temperature

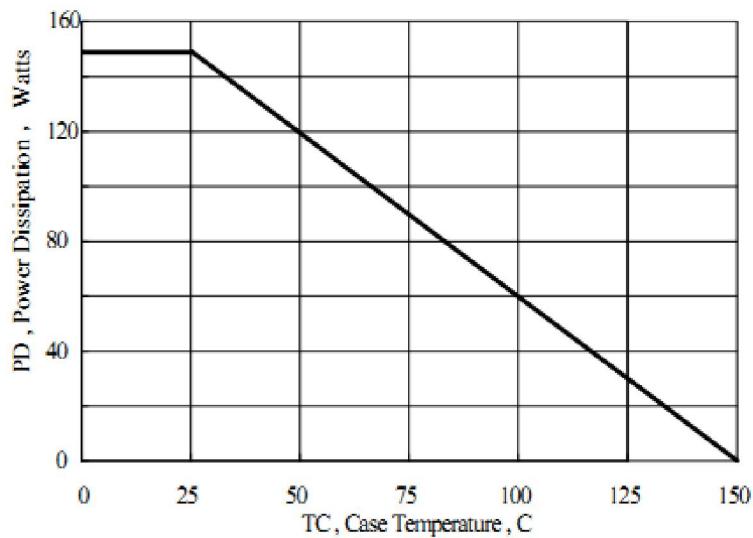


Figure 3. Max. Drain Current vs Case Temperature

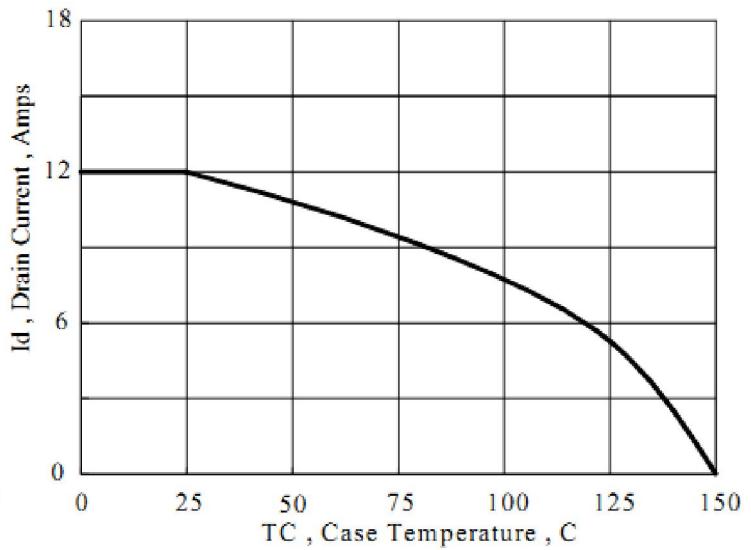


Figure 4. Typical Output Characteristics

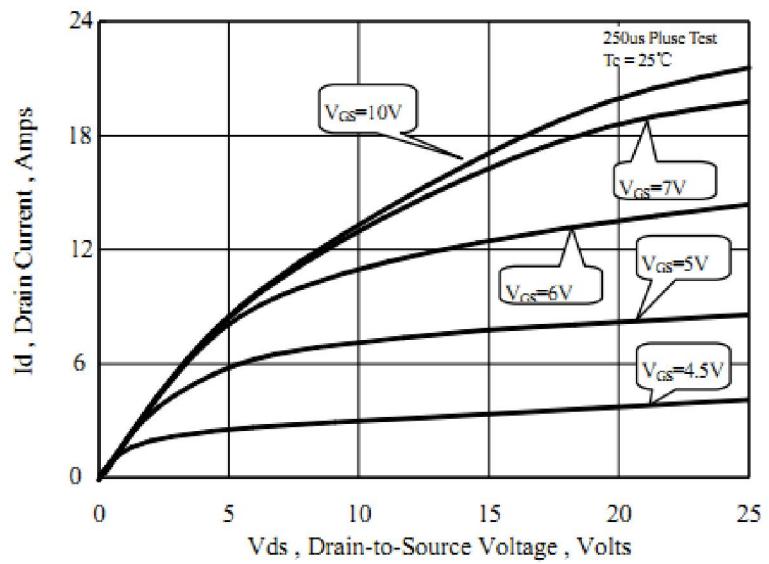
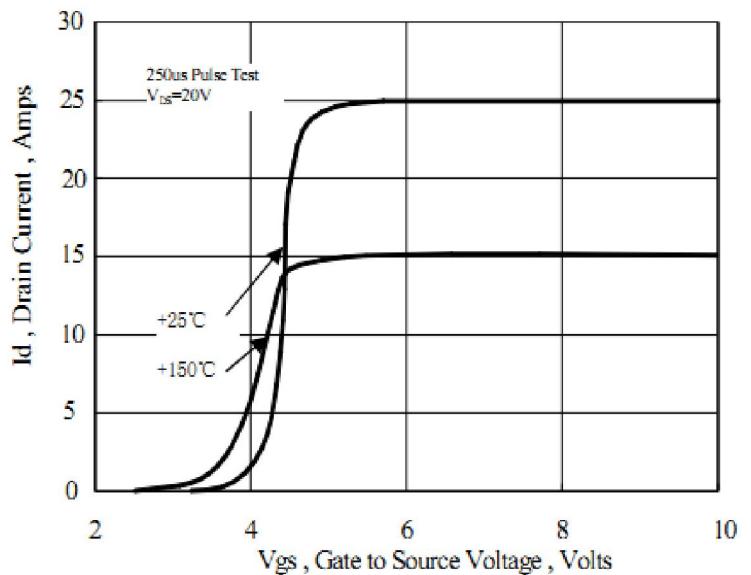
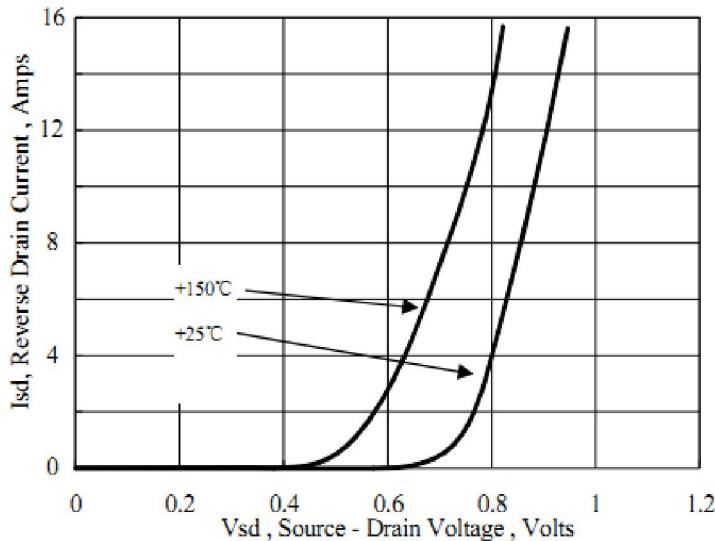
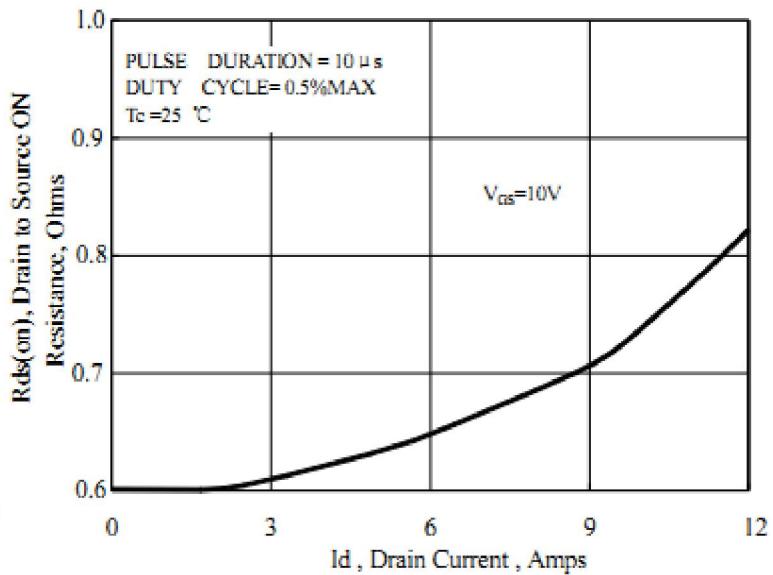
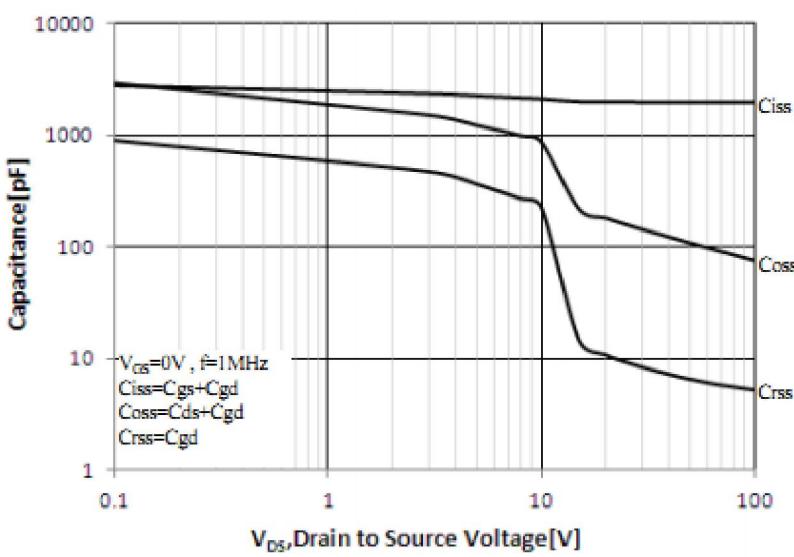
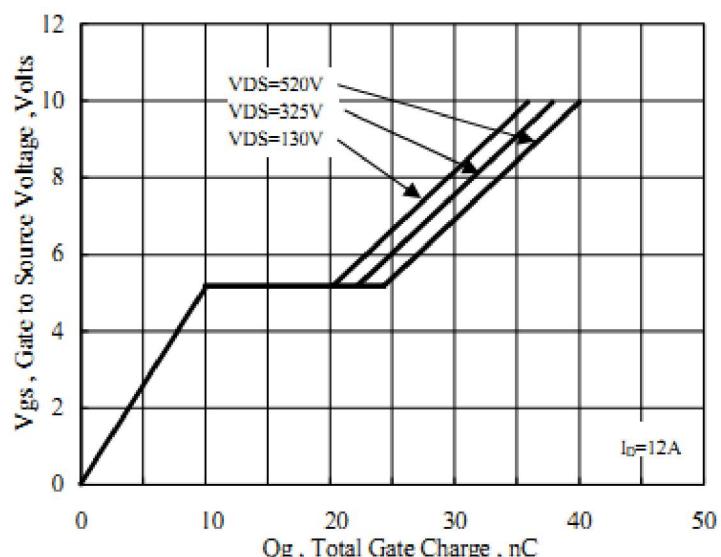
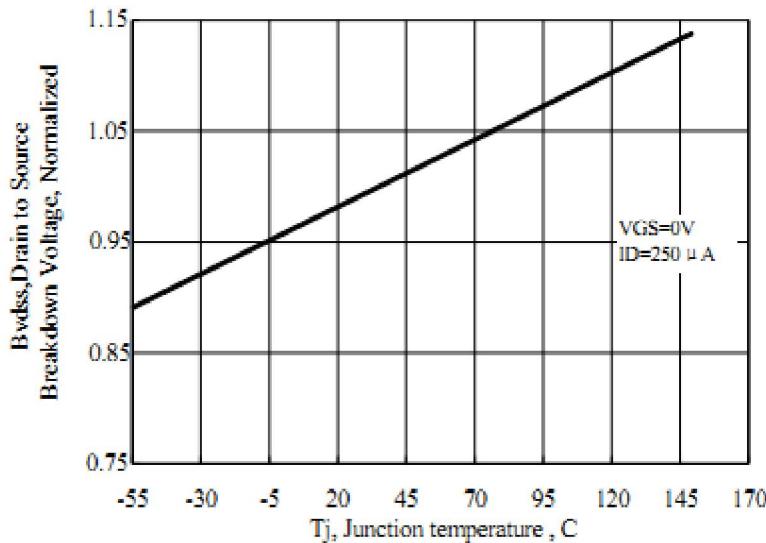
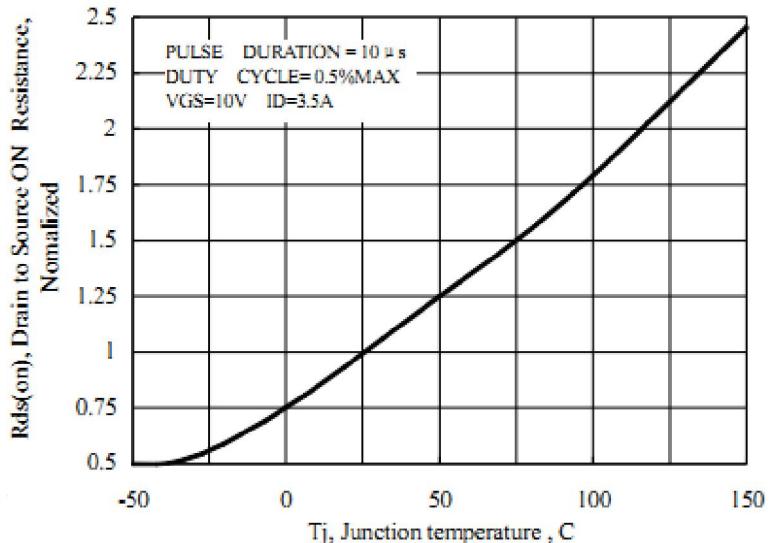
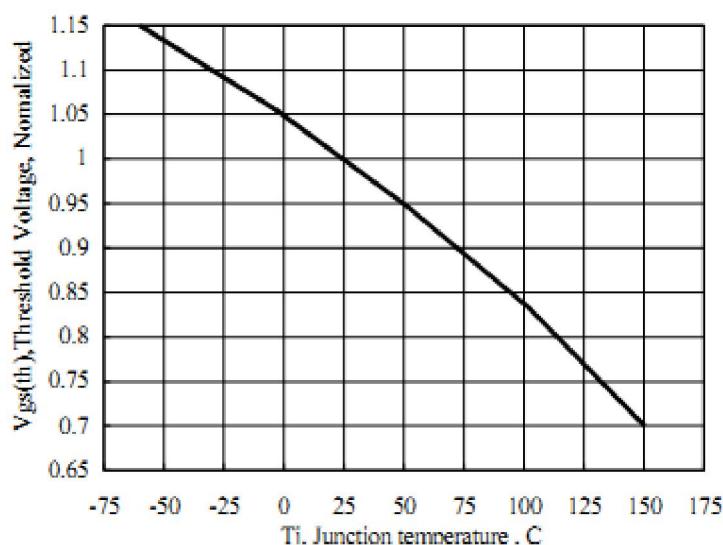
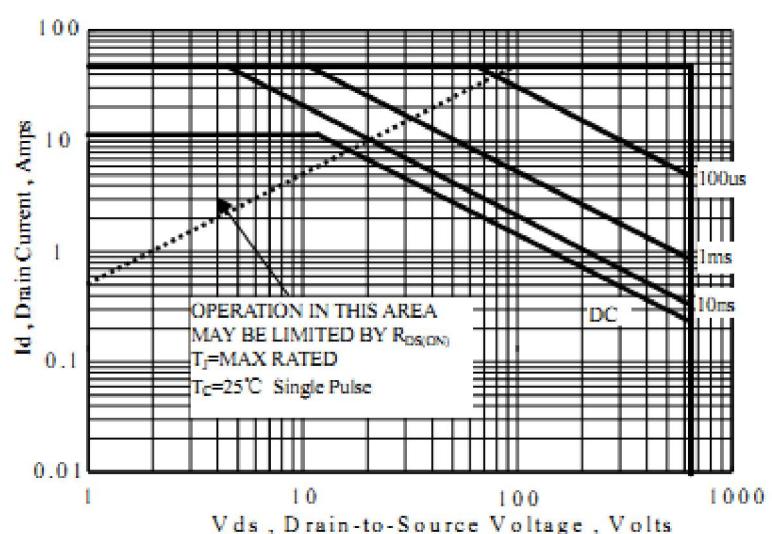


Figure 5. Typical Transfer Characteristics

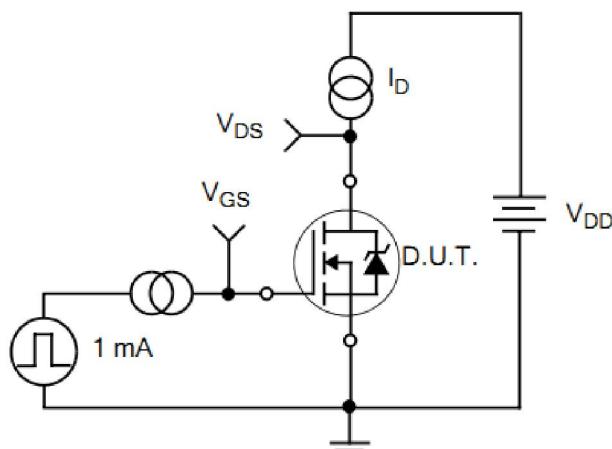


**Figure 6. Typical Body Diode Transfer Characteristics**

**Figure 7. Typical on Resistance VS Drain Current**

**Figure 8. Capacitance VS Drain-to-Source Voltage**

**Figure 9. Gate Charge VS Gate-to-Source Voltage**


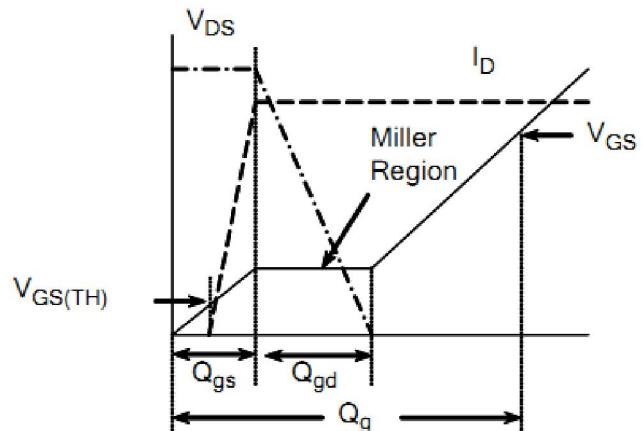
**Figure 10. Breakdown Voltage VS Temperature**

**Figure 11. on-Resistance VS Temperature**

**Figure 12 Threshold Voltage vs Junction Temperature**

**Figure 13. Safe Operating Area**


## Test Circuits and Waveforms

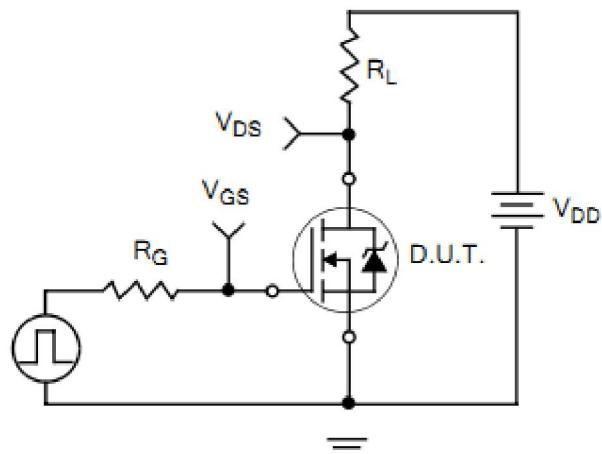
**Figure 14. Gate Charge Test Circuit**



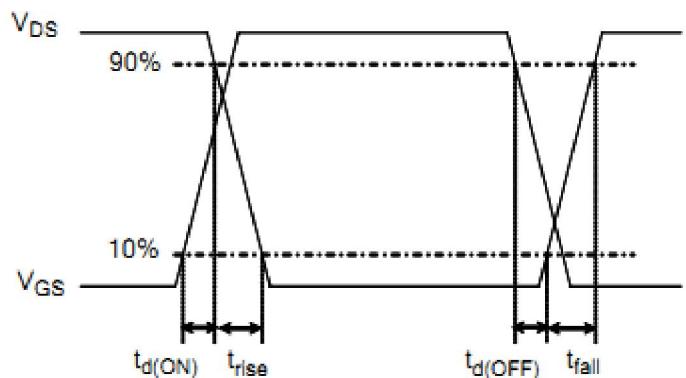
**Figure 15. Gate Charge Waveforms**



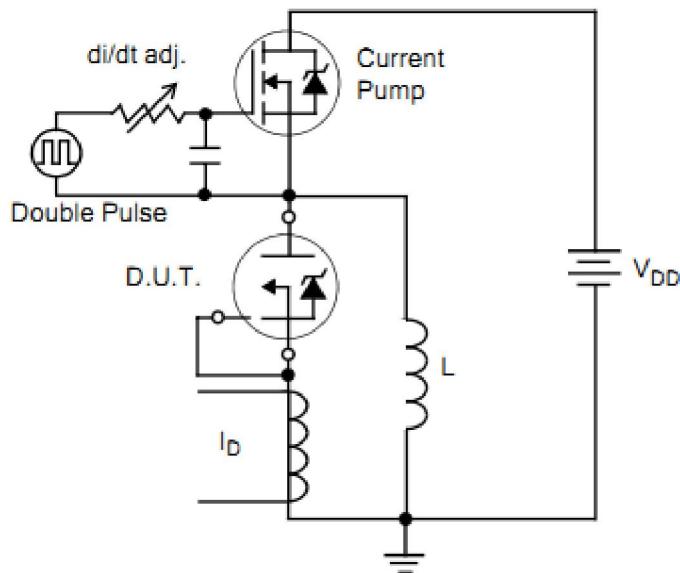
**Figure 16. Resistive Switching Test Circuit**



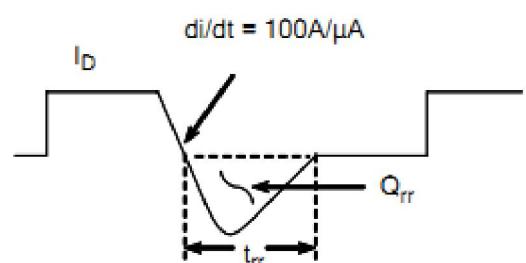
**Figure 17. Resistive Switching Waveforms**



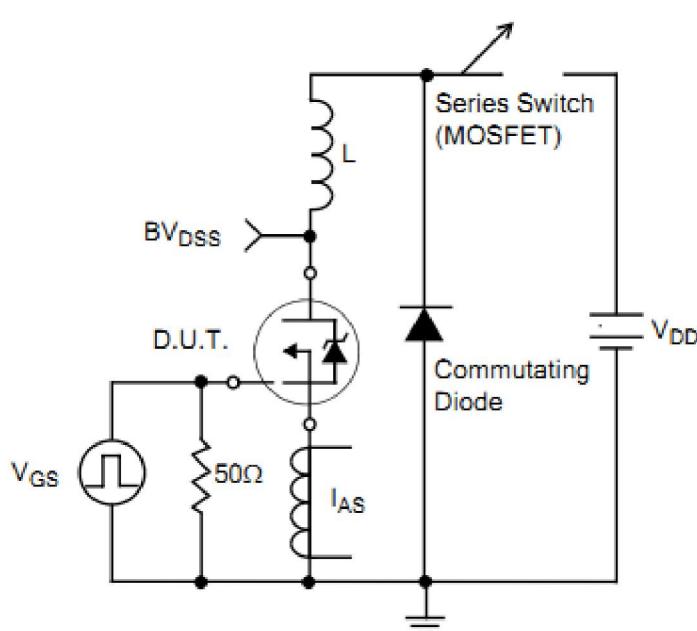
**Figure 18. Diode Reverse Recovery Test Circuit**



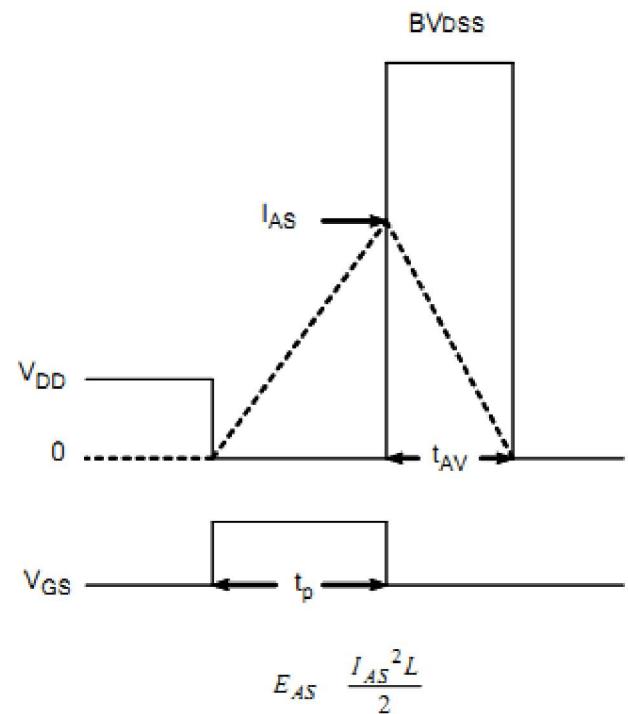
**Figure 19. Diode Reverse Recovery Waveform**



**Figure 20. Unclamped Inductive Switching Test Circuit**



**Figure 21. Unclamped Inductive Switching Waveform**



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